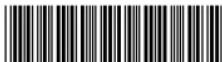


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10579034	NINOMIYA ET AL.
<b>Examiner</b>		<b>Art Unit</b>
Kim-Kwok CHU		2627

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
369	47.53	11/17/2010	kc
369	13.4	11/17/2010	kc
369	116	11/17/2010	kc
369	94	11/17/2010	kc
369	30.27	11/17/2010	kc
369	53.12	11/17/2010	kc

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
East Search	11/17/2010	kc
Applicant Application Search	11/17/2010	kc

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>